

ILC-HiGrade cavities as a tool of quality control for the EXFEL and further SRF R&D

- Motivation and goal
- European EXFEL/ILC-HiGrade program
- Results of cold RF test of the EXFEL/ILC-HiGrade cavities
- Quality control tools and actual results



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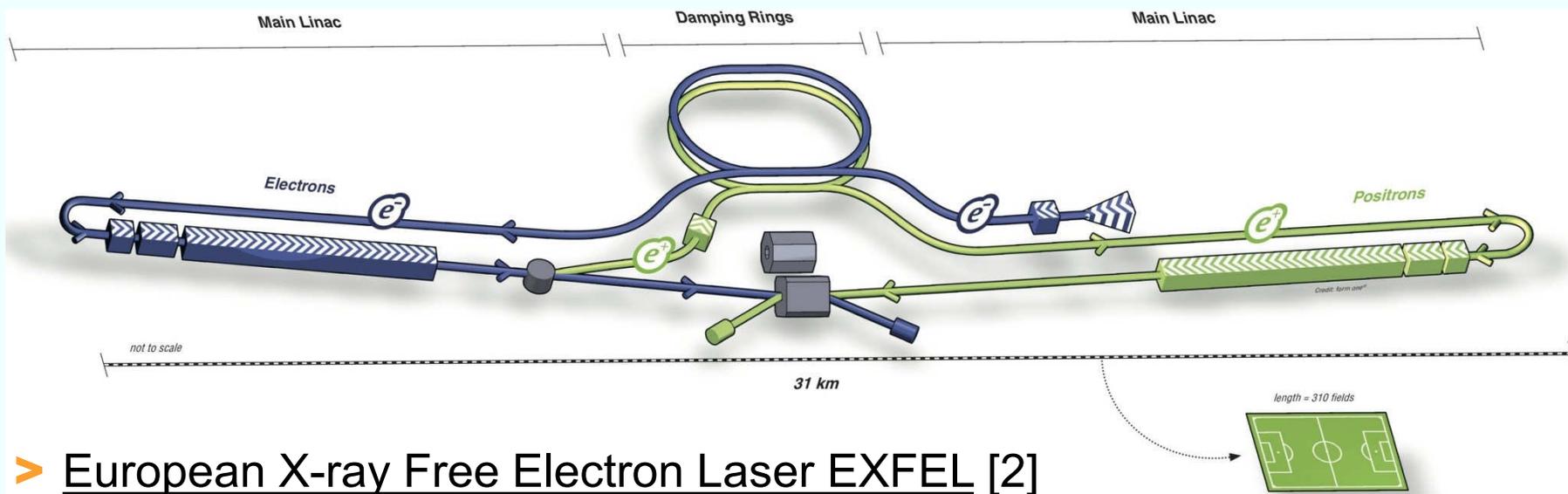
Bundesministe
für Bildung
und Forschung



Motivation for high gradient superconducting (SC) cavities:

> The International Linear Collider ILC [1]

- Centre-of-mass energy 500 GeV, 31 km long, TDR 12 June 2013
- 16,000 1.3 GHz 9-cell Nb cavities, gradient E_{acc} at least 35 MV/m
- Average E_{acc} in the cryomodule: 31.5 MV/m @ quality factor $Q_0 > 10^{10}$



> European X-ray Free Electron Laser EXFEL [2]

- 800 SC 1.3 GHz 9-cell cavities, production **is ongoing**
- Nominal gradient $E_{\text{acc}} = 23.6 \text{ MV/m} @ Q_0 > 10^{10}$
- 17.5 GeV beam energy, 3.4 km long

An excellent large-scale prototype for the ILC



[1] <http://www.linearcollider.org> [2] www.xfel.eu

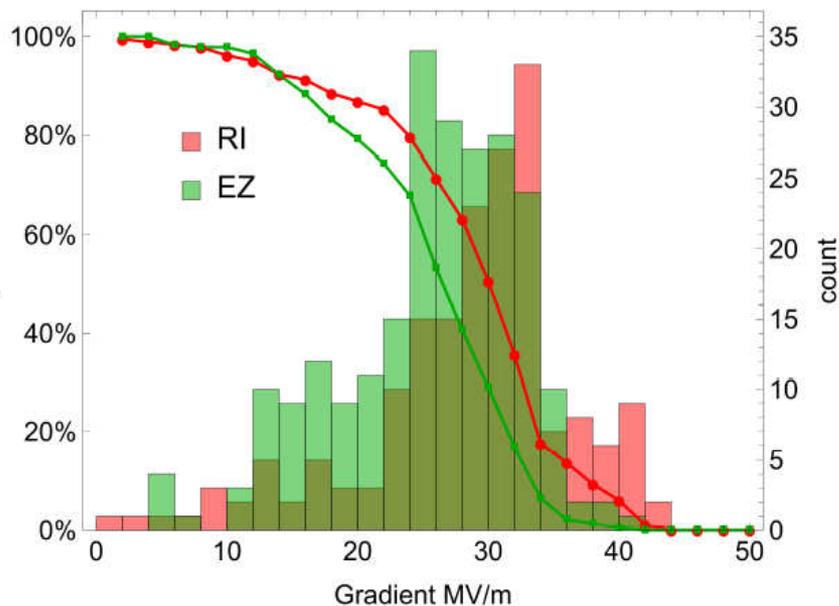
➔ 24 cavities are added to the EXFEL order:

- > Initially, serve as quality control (QC) sample for the EXFEL
 - extracted regularly, ~one cavity/month
 - after the normal acceptance test are taken out of the production flow --> R&D
- > Delivered with full treatment but no helium tank
 - > maximize the data output from the test

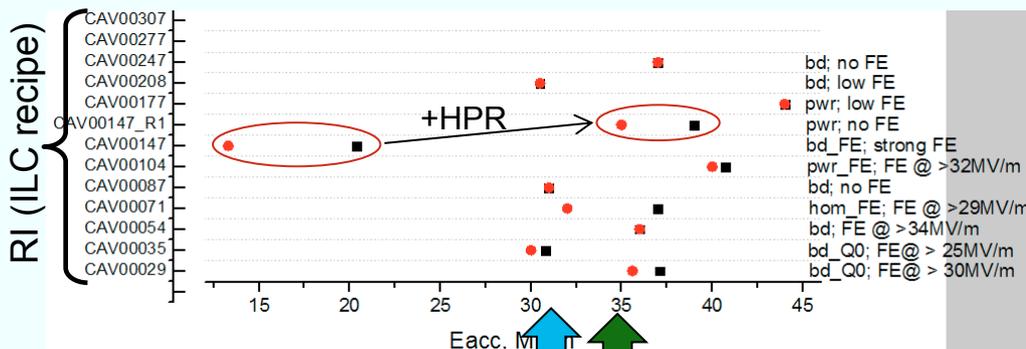
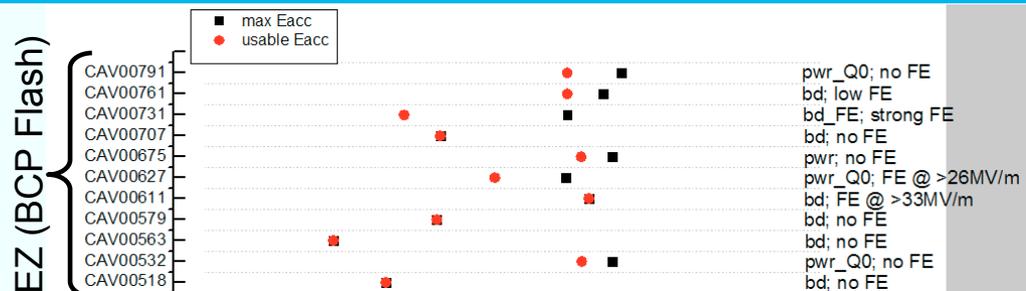
22 out of 24 already delivered

Cold RF results of EXFEL & ILC-HiGrade cavities

Usable gradient of EXFEL cavities (as received*)



	RI	EZ	Total
Tests	182	231	413
G_{AVG} (MV/m)	28.6	25.5	26.9
G_{RMS} (MV/m)	7.9	6.9	7.5
yield @ 20MV/m	87%	79%	83%
yield @ 26MV/m	71%	53%	61%
yield @ 28MV/m	63%	41%	51%



- “ILC recipe” provides cavities with usable gradient of $\sim 31.9 \pm 8.2$ MV/m (34.9 ± 4.7 MV/m after retreatment)
- some achieve >40 MV/m

- Main limitation is **FE**

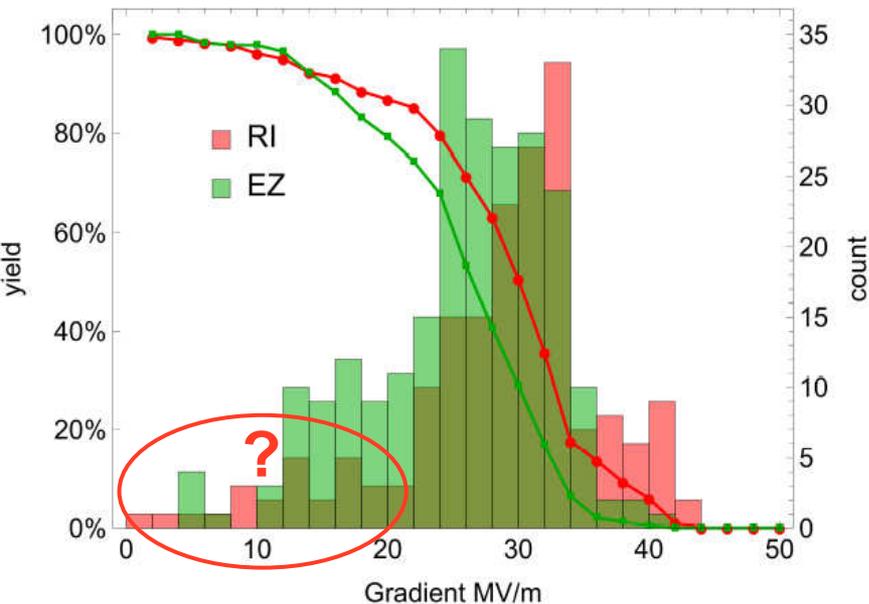
Usable gradient:

- E_{acc} of quench or
- E_{acc} at $Q_0 \leq 1 \times 10^{10}$ or
- E_{acc} at excess of X-ray radiation:
 >0.01 (0.12) mGy/min for upper(lower) detector

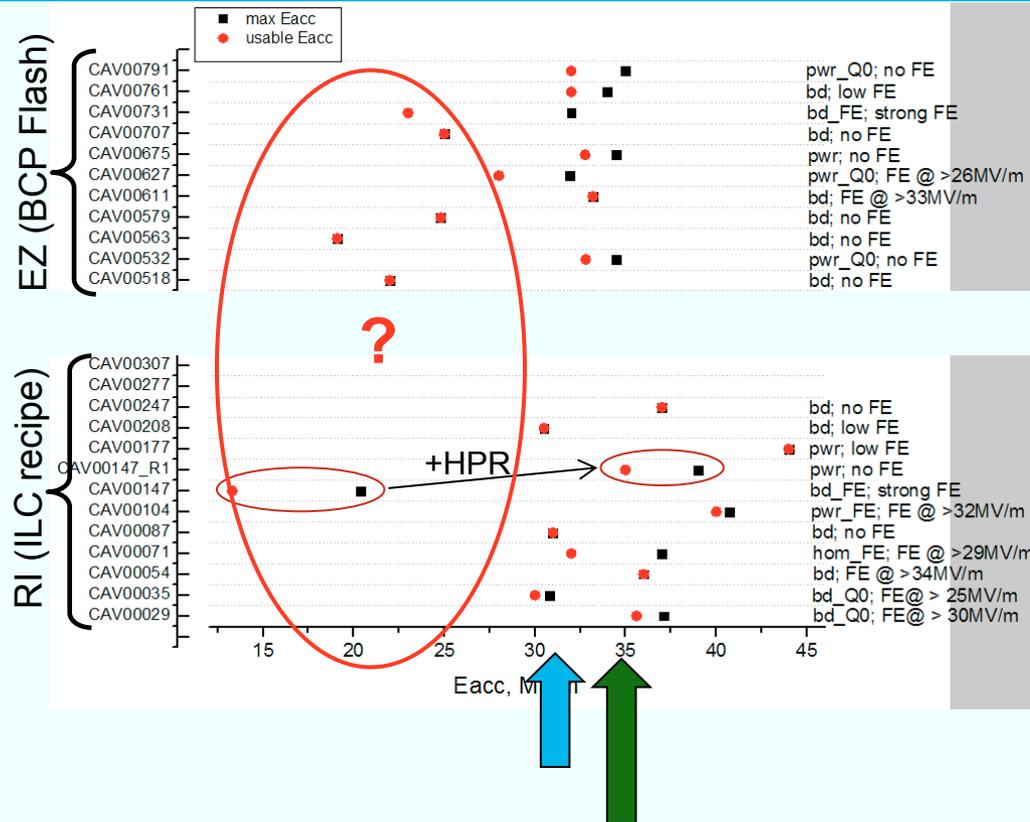
*D. Reschke, TTC Meeting KEK, Dec 2-5, 2014

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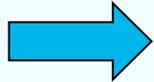
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Goal

- > Clear identification of the limiting factors:
 - > suspicious EXFEL cavities (mainly with usable $E_{\text{acc}} \leq 20$ MV/m)
 - > all ILC-HiGrade cavities



Additional techniques used:

- Cold RF tests in different “passband modes” for localization of limiting cells
- “2nd sound” and “T-mapping”
for localization of thermal breakdowns (quenches)
- Optical (OBACHT) and replica surface inspection

**see more talk R. Laasch*

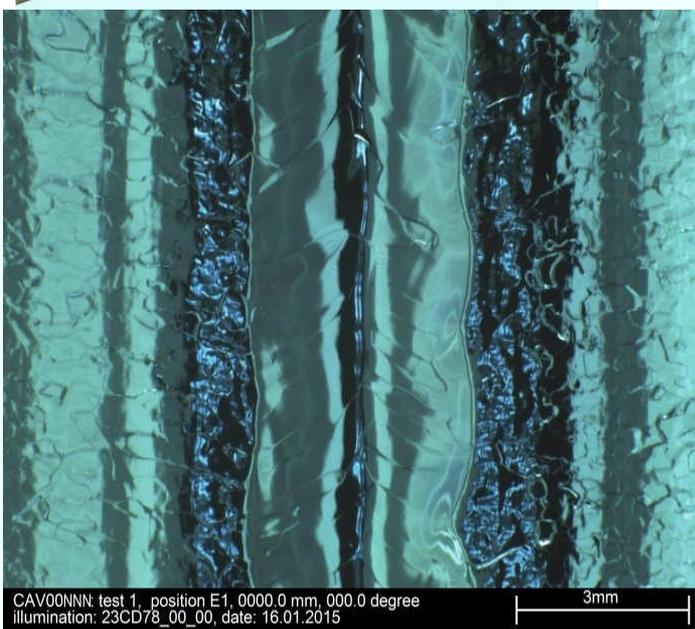
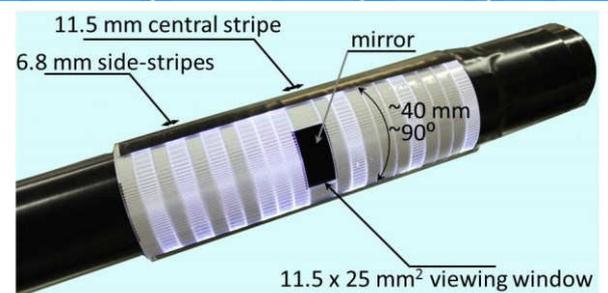
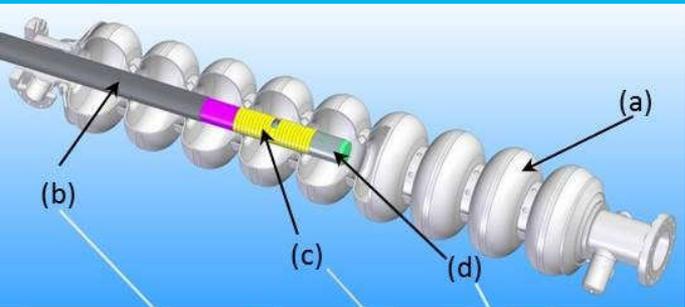
- > Elaboration of further treatments:
(providing e.g. $E_{\text{acc}} \geq 35$ MV/m @ >90% yield as the ILC goal)

- additional High Pressure ultrapure water Rinsing (HPR)
- additional chemical polishing (BCP) or electropolishing (EP)
- Centrifugal Barrel Polishing (CBP)
- Local grinding repair

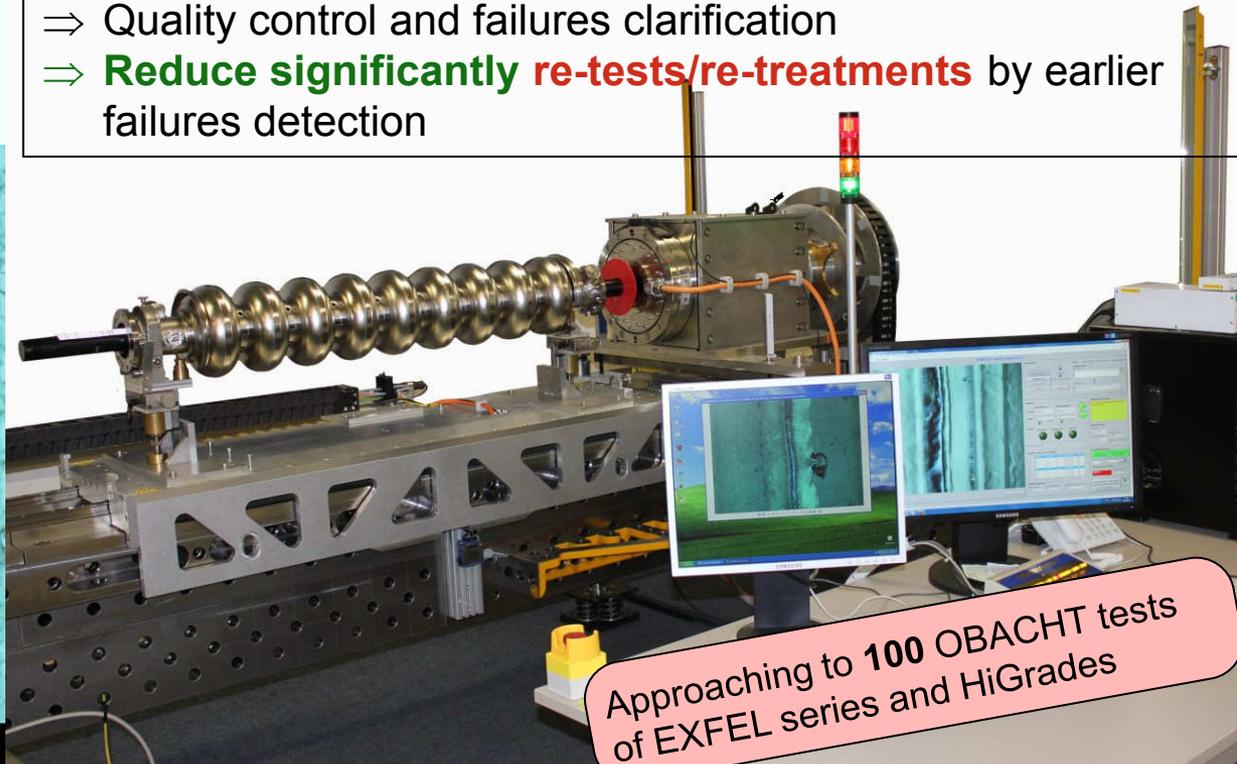
**see more talk Y. Tamashevich*

- > Further improve quality control to reduce the retreatment rate

OBACHT – Optical Bench for Automated Cavity Inspection with High Resolution on Short Time Scales



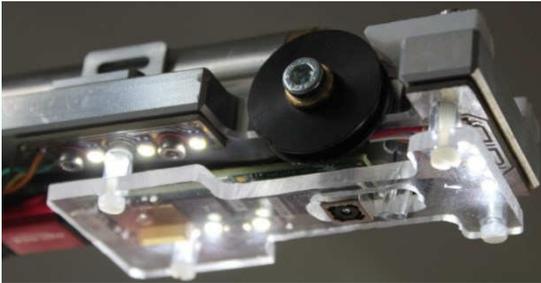
- > Optical inspection tool for cavity inner surface (mainly welding seams)
- > Semi-automated (LabView) tool based on “Kyoto camera” (Y. Iwashita, PRST AB, 11, 093501 (2008)):
 - ~10 μm resolution
 - special distributed illumination
- > Automatic positioning, illumination, and image recording at predefined positions
 - ⇒ Quality control and failures clarification
 - ⇒ **Reduce significantly re-tests/re-treatments** by earlier failures detection



Approaching to **100** OBACHT tests of EXFEL series and HiGrades

“Replica” surface profilometry

- “Replica” is used for non-destructive profilometry studies of inner surface: conspicuous surface features or defects



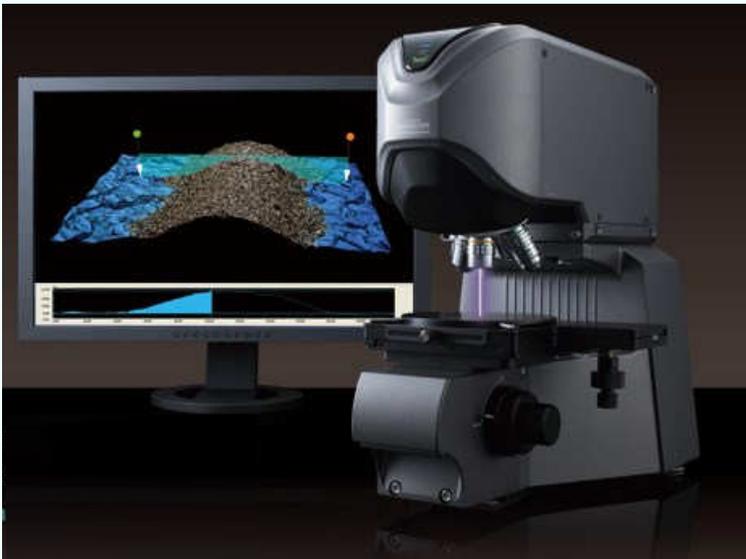
“Replica” tool with camera



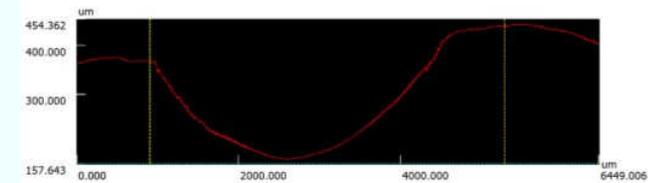
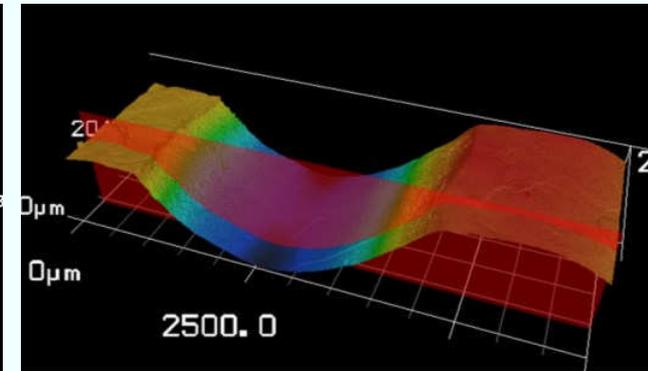
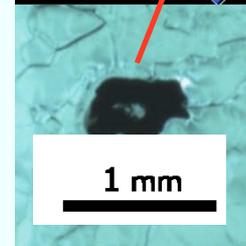
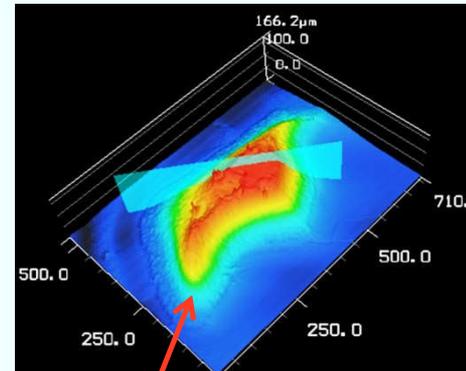
“Replica” tool in the cavity



Silicon rubber on the surface

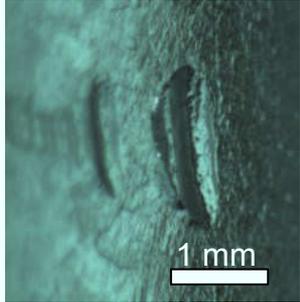


* Keyence 3D Laser scanning microscope



~1 μm resolution (3D topography) has been achieved
- no cavity degradation (no residues) if done correctly (at least after HPR)

Scratches



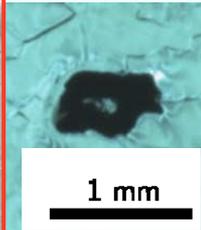
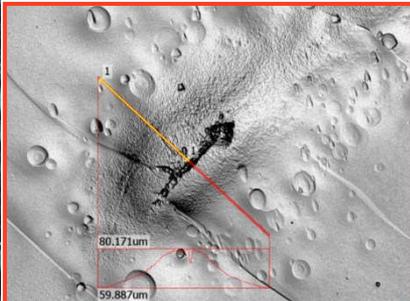
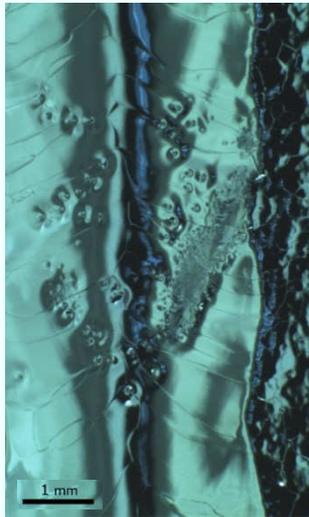
=> **Handling failures:**

- ⊖ Strong x-ray radiation
- ⊖ Complicated repair required (tank removal, mechanical polishing inside cavities, and 2nd whole surface prepare pass)
- ⊕ Some failures identified and fixed

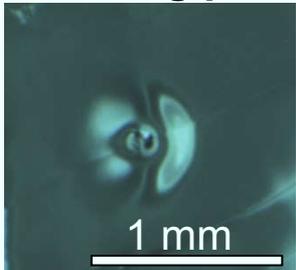
Pits or inclusions

=> Foreign material inclusions:

- ⊖ Low field quenches
- ⊖ Influence polishing process
- ⊖ Complicated repair required



“Etching pits”

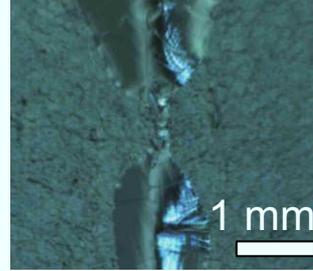


=> **Etching effect (H₂ bubbles):**

- ⊕ No influence in high magnetic field regions (equators)
- ⊖ Might lead to radiation in high electric field regions (irises)

Typical surface defects (EXFEL and ILC-HiGrade cavities)

Incomplete weld



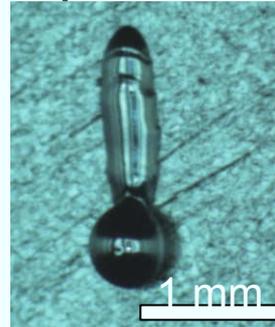
=> Wrong welding parameters:

- ⊖ Lead to low field quenches
- ⊖ Complicated repair required
- ⊖ Pressure issue

⊕ Ruled out by electron-beam welding optimization

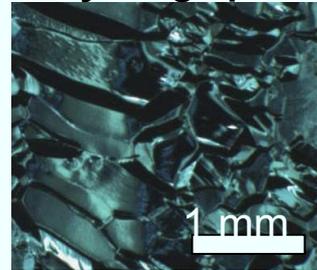
“Spatters”

“Spatters”



- => **Welding failures due to sparks or presence of dust**
- ⊖ Low field quenches
 - ⊖ Mechanical polishing inside cavities required

“Very rough polishing”



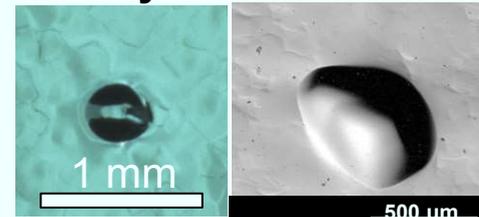
=> **Wrong etching parameters**

⊖ Lead to low Q_0 and low field quenches

⊕ Ruled out by better parameters optimization and control

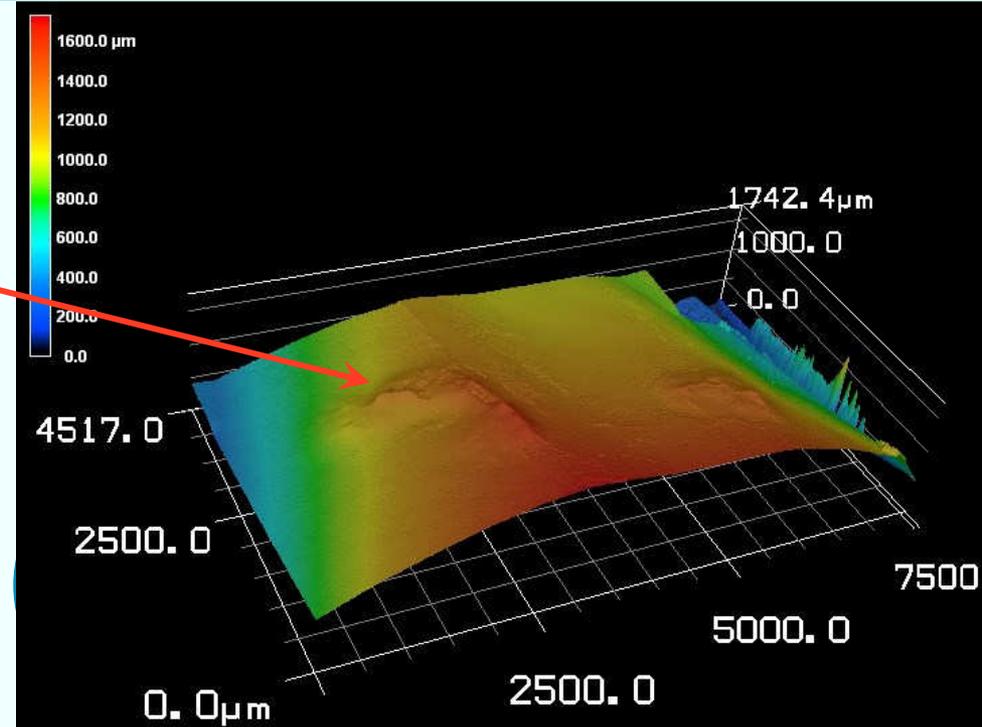
Typical surface defects (EXFEL and ILC-HiGrade cavities)

“Cat eyes”



- => **Voids in the surface**
- ⊕ Seems to be harmless
 - ⊕ No performance degradation observed

Typical surface defects: scratches

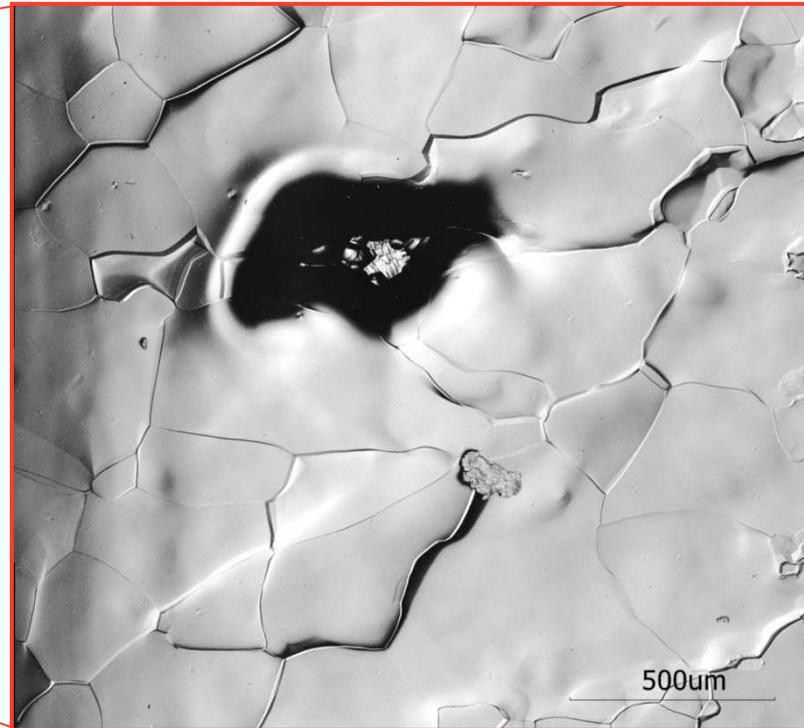
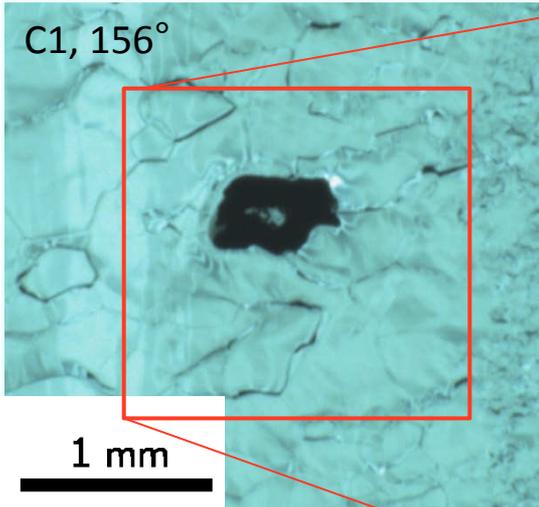


- > $E_{\text{acc,max}} = 23 \text{ MV/m}$, limited by quench with strong radiation, $E_{\text{acc,usable}} = 16 \text{ MV/m}$
- > Retreatment by add. HPR and $10 \mu\text{m}$ BCP did not improve the performance, made even worse
- > Several mm-wide protrusions with at least $100 \mu\text{m}$ height found on almost all irises at the same angle
- > Error: scratched by bent EP electrode

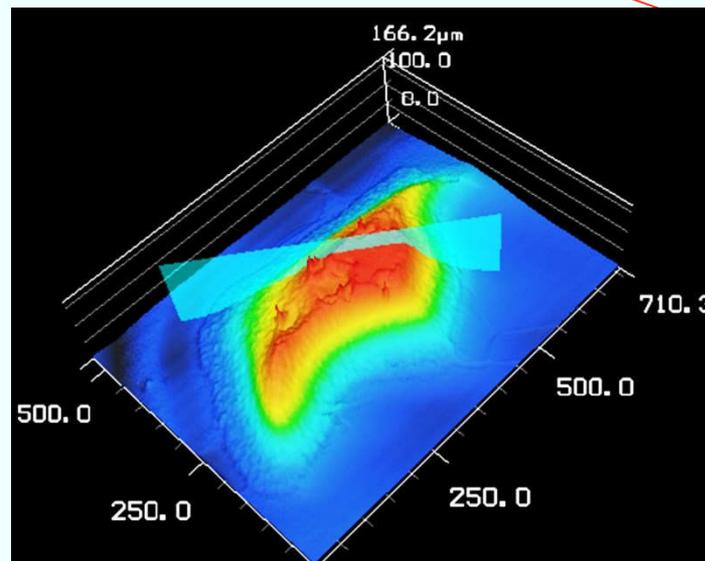
Typical surface defects: foreign inclusions

OBACHT image

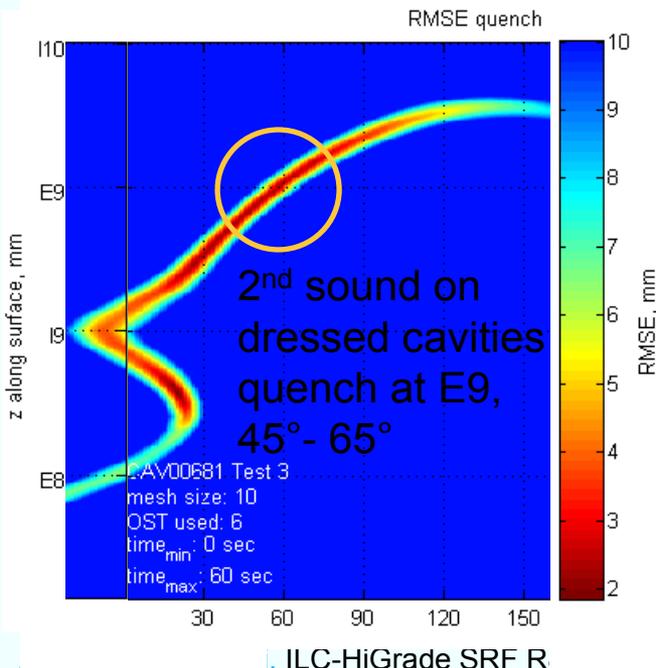
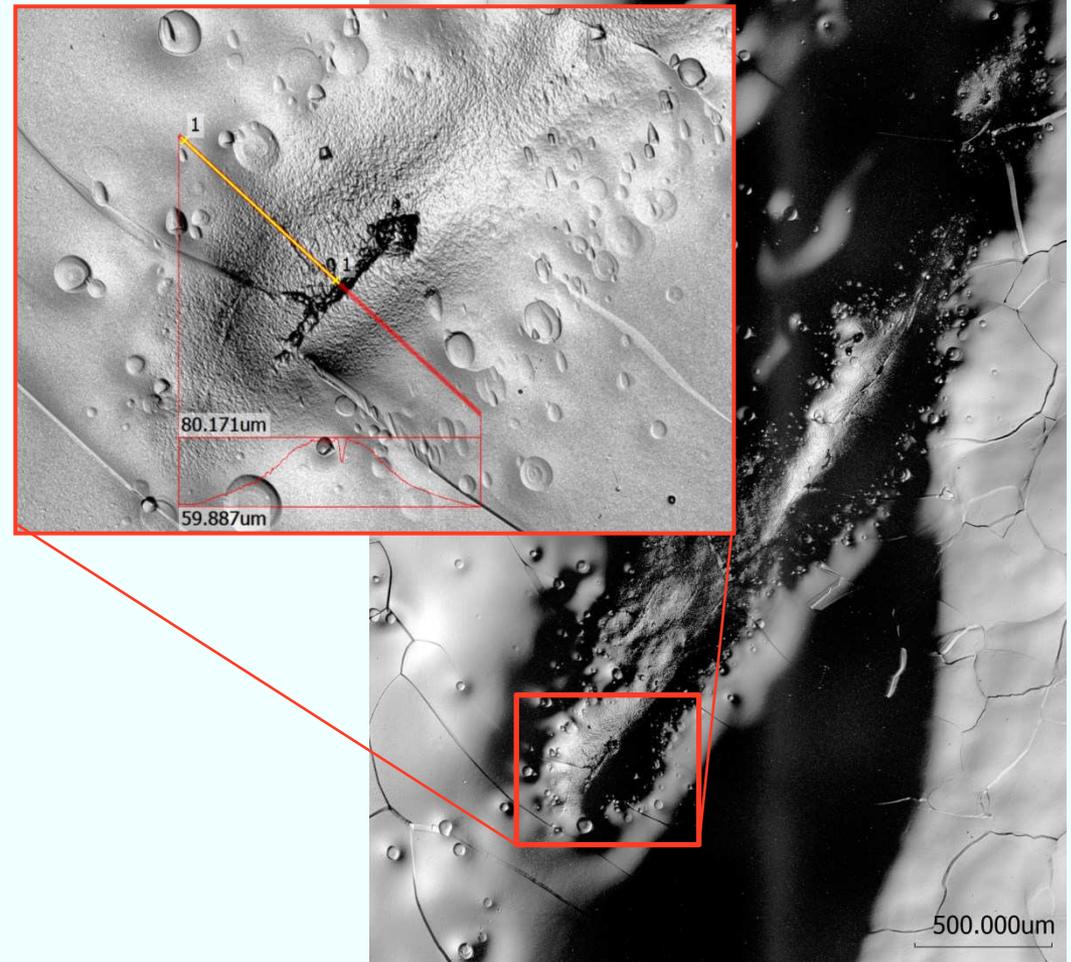
C1, 156°



- $E_{\text{acc,max}} = 16 \text{ MV/m}$, limited by quench
- Height of the defect is $\sim 124 \mu\text{m}$
- Most probably a foreign inclusion not affected by polishing
- No deviations seen on the initial Nb sheet
=> defect appeared during fabrication



Typical surface defects: foreign inclusions

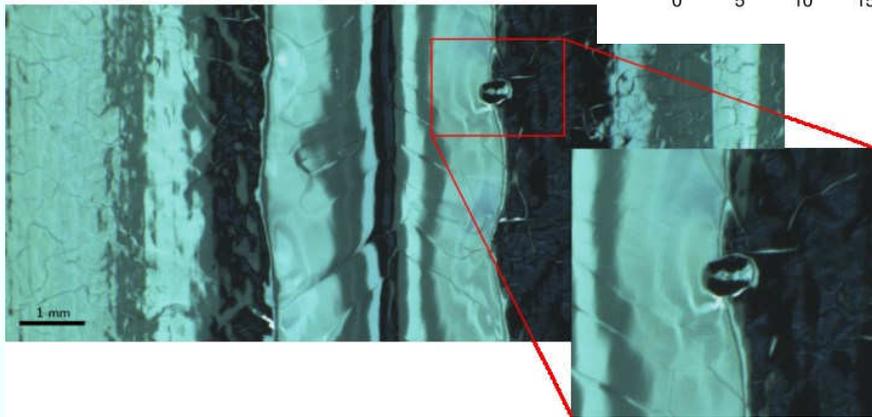
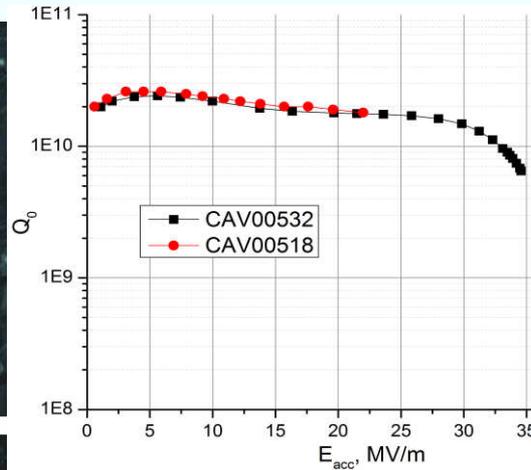
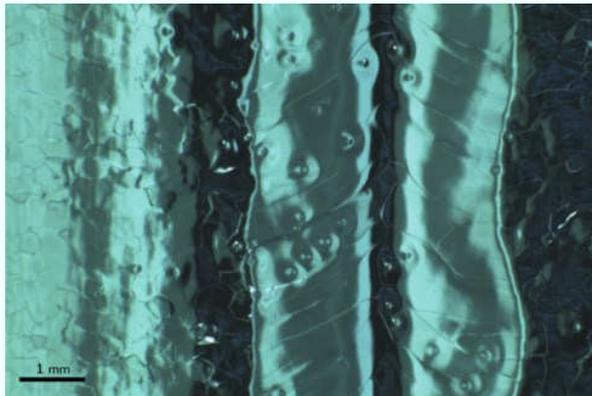


- $E_{acc,max} = 16 \text{ MV/m}$, limited by quench
- Etching defect due to contamination during welding
- Repair under discussion

Cold RF tests vs. surface quality

CAV00532:

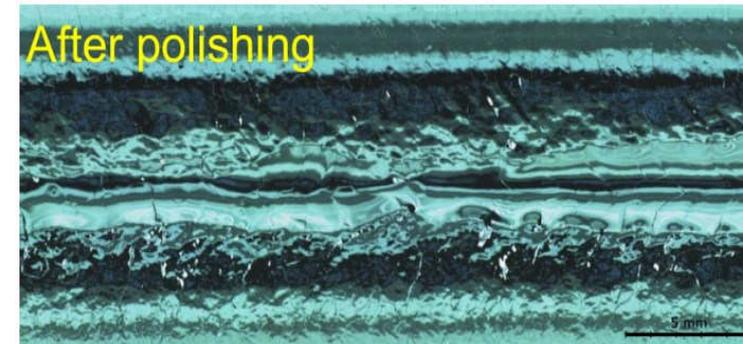
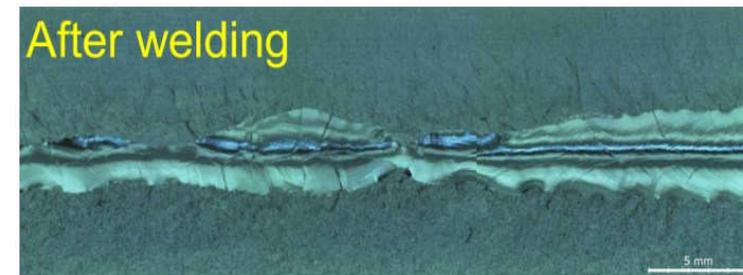
→ **Successful** cold RF test result with **no FE**, RF power limited at 200W P_{in})



→ **Nice** RF result despite of “pits” and “cat-eyes” on the surface

CAV00518:

→ Unsuccessful cold RF test result with quench at **22 MV/m**, **no FE**

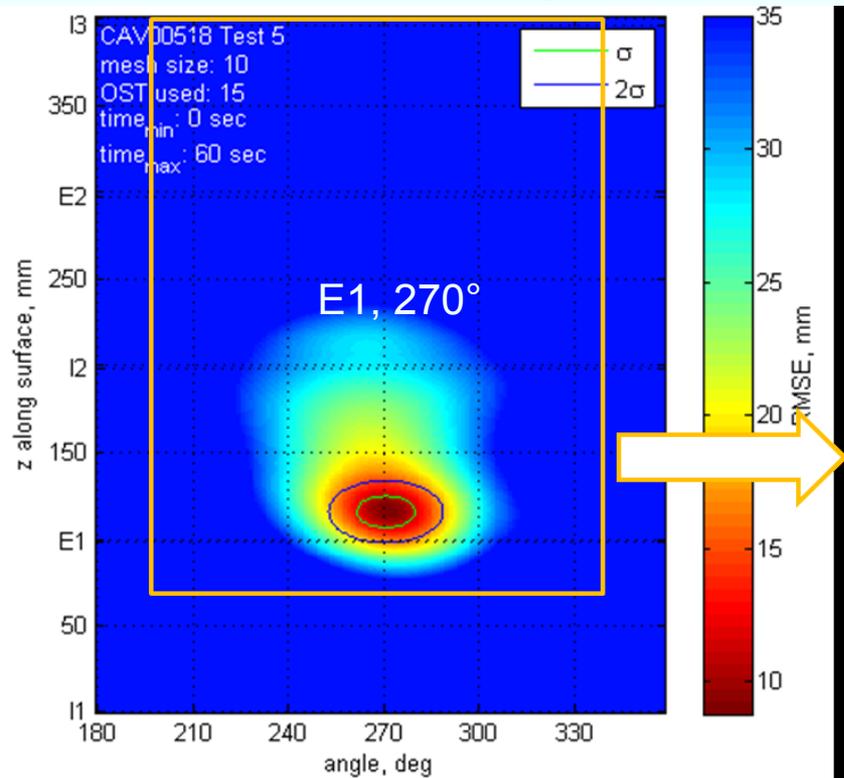


→ OBACHT indicates defective welding as a possible quench reason

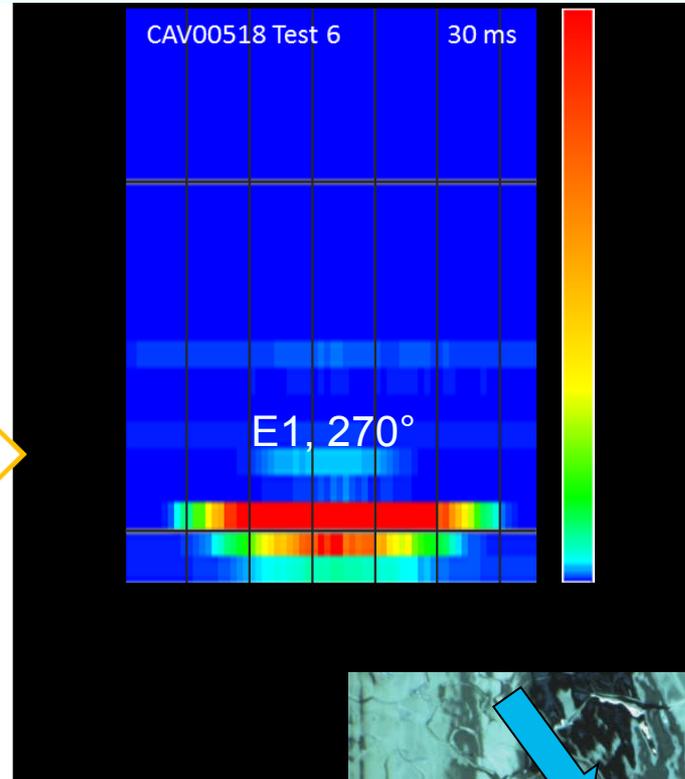
→ **“2nd Sound”** & **“T-mapping”** is applied for the quench localization and further studies

Welding errors: 2nd sound vs. T-mapping

“2nd Sound “map”

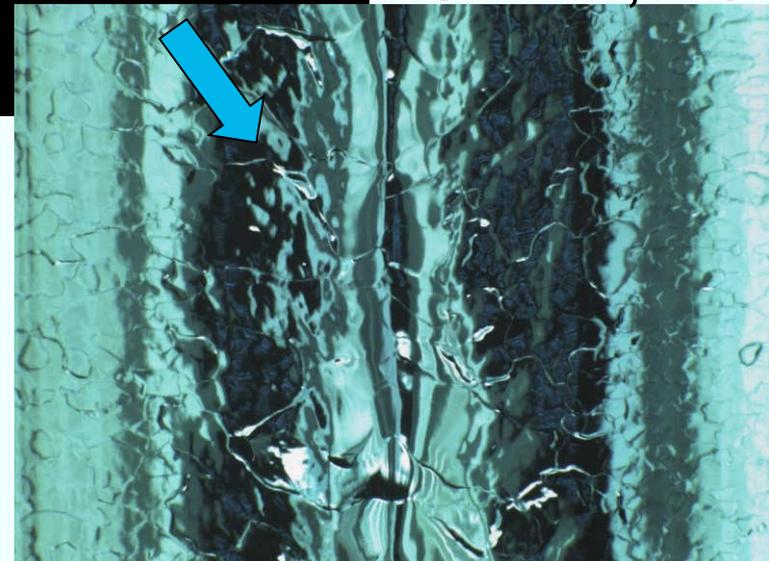


Temperature map



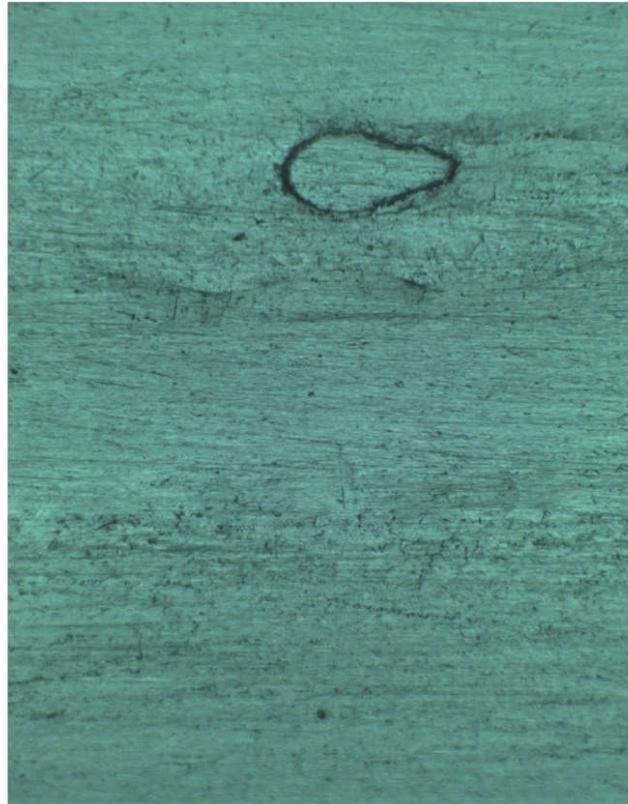
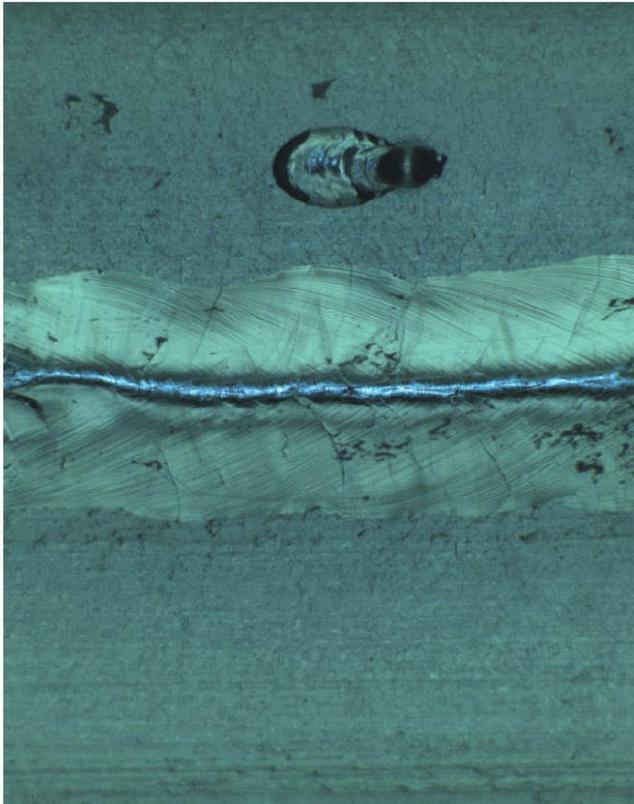
OBACHT: E1, 270°

- ⇒ Quench at 24MV/m, localized on the E1, 270°
- ⇒ **Good agreement** between T- and 2nd-sound mapping
- ⇒ OBACHT indicates **defective welding** as a possible quench reason



Typical surface defects: welding spatters

Endoscopes & OBACHT (shown here) inspections discover some “spatters” occasional occurring during the welding:

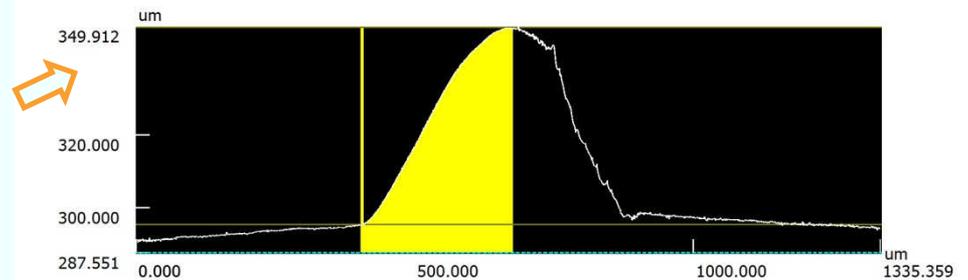
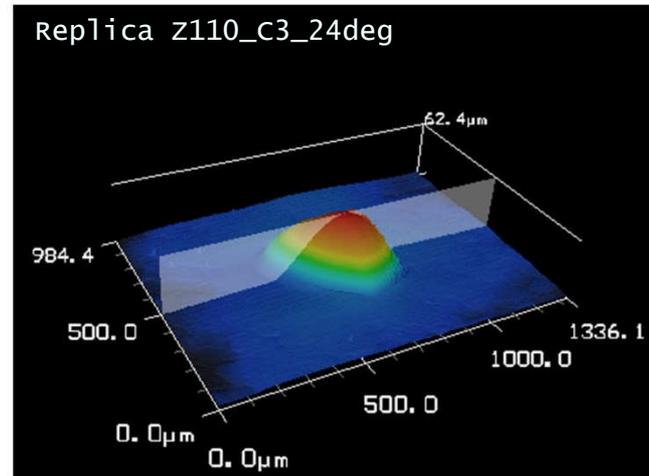
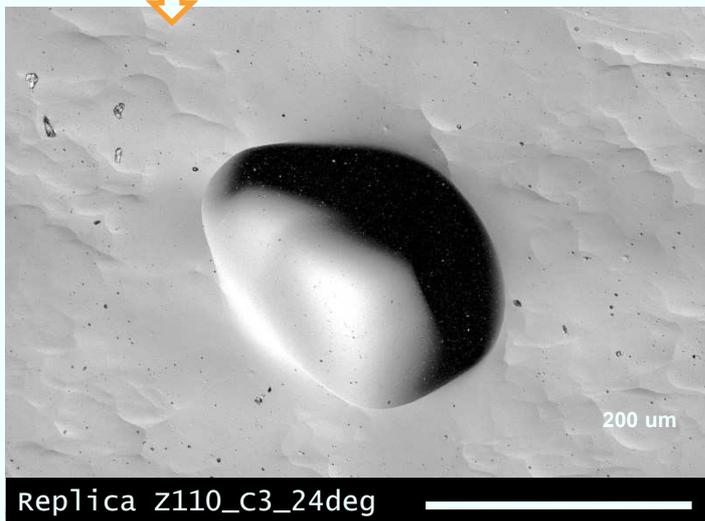
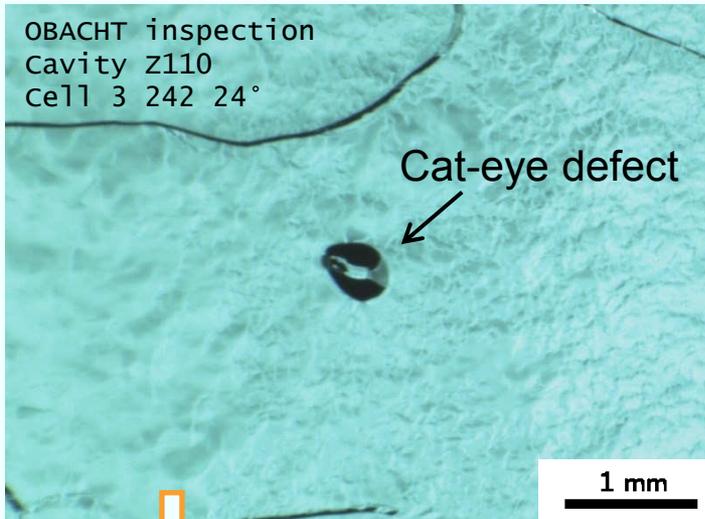


After final polishing:

→ max $E_{acc} = 30.5 \text{ MV/m}$
→ no FE

- **reasons:** - blasts due to contamination
- sparks due to defective high voltage regulation of the electron beam welding machine
- an **additional grinding/repair** is required
- repair procedure using local grinder has been commission (manual one shown here)

Replica: defects investigation



Profile1	Horz. dist.	Hght. diff.	Hght. ave.	Angle	C.S. length	C.S. area	R	Comment
All	1335.359um	3.733um	306.016um	0.160°	1408.183um	24670.176u...		
Seg.1	268.152um	54.050um	325.731um	11.396°	278.242um	10276.218u...		

Pit in the surface. Depth 55 μm

Thank you for your attention !

Acknowledgements:

- **FLA/ILC, MPL, MKS 1, MKS 3, and MHF-sl groups**
- **all DESY and INFN colleagues** involved in the XFEL cavity fabrication, treatment and tests
- **KEK colleagues** and especially to Takayuki Saeki and Shigeki Kato for help with the fabrication of the coupon cavity
- **FNAL colleagues** and especially A. Romanenko, A. Grassellino, and C. Cooper for valuable discussions

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